## Applicant(s)/Patent Under Application/Control No. Reexamination 10/771,411 TAKATSUJI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1745 Julian Mercado U.S. PATENT DOCUMENTS Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 429/94 10-2004 Hosoya, Yosuke US-6,805,996 Α \* US-6,783,890 429/218.1 08-2004 Kweon et al. В \* 429/231.3 US-7,150,940 12-2006 Okochi et al. С US-D US-Ε US-F US; G ∕US-Н US-US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY H01M 4/58 06-150929 05-1994 Japan Okamura et al. Νź 0 Ρ Q R S Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х \*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.